

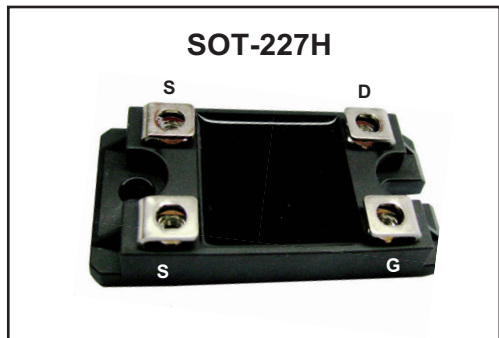
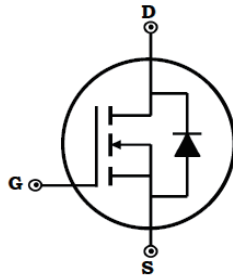


N-Channel Enhancement Mode MOSFET

Features

- ◆ $V_{DS} = 100V$
- ◆ $R_{DS(ON)} < 0.8\ m\Omega @ V_{GS} = 10\ V$
- ◆ Fully Avalanche Rated
- ◆ Pb Free & RoHS Compliant
- ◆ Isolation Type Package
- ◆ Electrically Isolation base plate

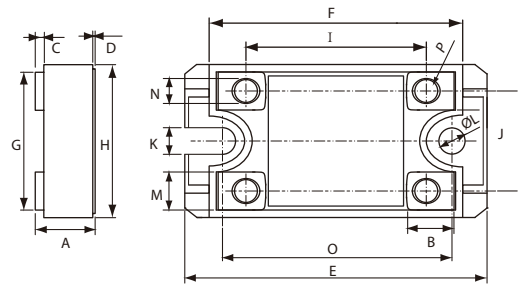
Preliminary



Applications

- ◆ Backlighting
- ◆ Power Converters
- ◆ Synchronous Rectifiers

Dimensions in inches and (millimeters)



Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current-Continuous @ $T_c = 25^\circ C$ @ $T_c = 100^\circ C$	I_D	1100 880	A
Drain Current-Pulsed @ $T_c = 25^\circ C$ ^{Note1}	I_{DM}	3200	A
Maximum Power Dissipation	P_D	1800	W
Storage Temperature Range	T_{STG}	-50 to +150	°C
Operating Junction Temperature Range	T_J	-50 to +150	°C
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.07	°C/W
Isolation Voltage (A.C. 1 minute)	V_{iso}	2500	V
Mounting torque (M4 Screw)	M_d	1.3	N _m

DIM	DIMENSIONS			
	INCHES		MM	
	MIN	MAX	MIN	MAX
A	0.516	0.532	13.10	13.50
B	0.355	0.374	9.00	9.50
C	0.075	0.091	1.90	2.30
D	0.014	0.033	0.35	0.85
E	2.541	2.557	64.50	64.90
F	2.104	2.120	53.40	53.80
G	1.127	1.143	28.60	29.00
H	1.253	1.269	31.80	32.20
I	1.448	1.468	36.75	37.25
J	0.812	0.827	20.60	21.00
K	0.201	0.217	5.10	5.50
L	0.201	0.217	5.10	5.50
M	0.307	0.323	7.80	8.20
N	0.169	0.185	4.30	4.70
O	1.931	1.946	49.00	49.40
P	M4*8			



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
OFF Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _{DS} =3mA	100	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} =0V, V _{DS} =100V	-	-	100	µA
Gate-Body Leakage	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	800	nA
ON Characteristics						
Gate Threshold Voltage	V _{TH}	V _{DS} =V _{GS} , I _{DS} =8mA	2.5	-	3.5	V
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} =10V, I _{DS} =400A	-	0.6	0.8	mΩ
Gate Resistance	R _G		-	1.9	2.9	Ω
Forward Transconductance	g _{fs}	V _{DS} > 2 I _D R _{DS(on)M} ^{Note1} , I _D =100A	-	127	-	S
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} =25V	-	144	-	nF
Output Capacitance	C _{oss}	V _{GS} =0V	-	7.8	-	
Reverse Transfer Capacitance	C _{rss}	Freq.=1MHz	-	5.4	-	
Switching Characteristics						
Turn-On Delay Time	t _{d(on)}	V _{DS} =50V V _{GS} =10V I _{DS} =500A	-	308	-	ns
Rise Time	t _r		-	210	-	
Turn-Off Delay Time	t _{d(off)}		-	572	-	
Fall Time	t _f		-	176	-	
Total Gate Charge at 10V	Q _g	V _{DS} =50V	-	2710	-	nC
Gate to Source Charge	Q _{gs}	V _{GS} =10V	-	678	-	
Gate to Drain Charge	Q _{gd}	I _{DS} =500A	-	577	-	
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V _F	T _J =25°C, I _F =800A	-	-	1.1	V
Diode Continuous Forward Current	I _F	T _C =25°C	-	-	880	A
Diode Pulsed Current ^{Note1}	I _{F,pulse}	T _C =25°C	-	-	3000	A
Reverse Recovery Time	t _{rr}	I _F =100A, V _{DS} =25V, di/dt=80A/µs	-	158	-	ns
Reverse Recovery Charge	Q _{rr}	I _F =100A, V _{DS} =25V, di/dt=80A/µs	-	457	-	nc

Notes:

1. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle < 2%.



Typical Characteristics

Fig 1. Power dissipation

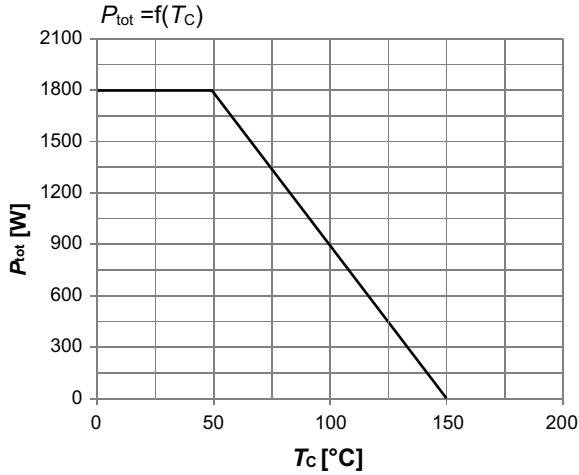


Fig 2. Drain current

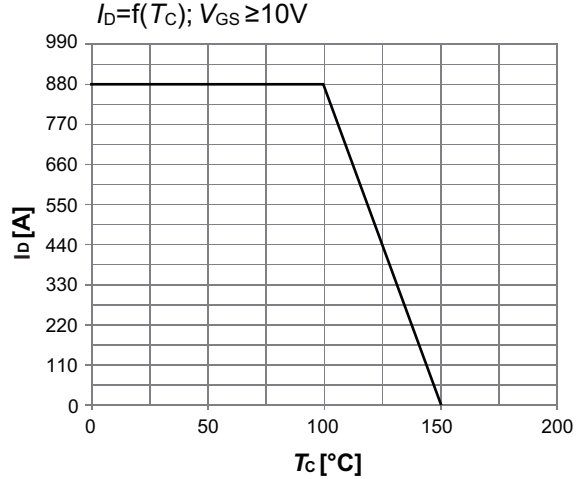


Fig 3. Safe operating area

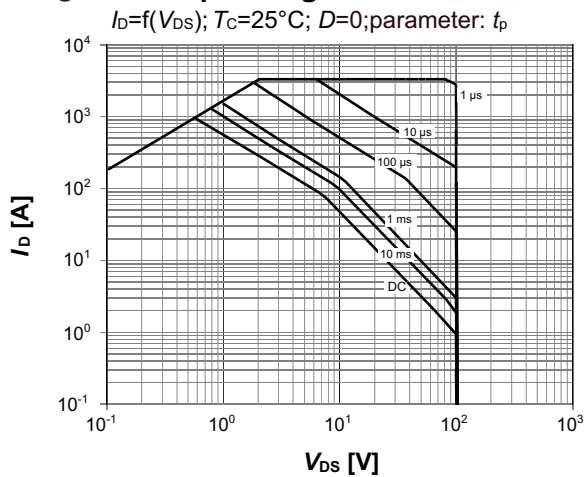


Fig 4. Maximum Transient Thermal Impedance

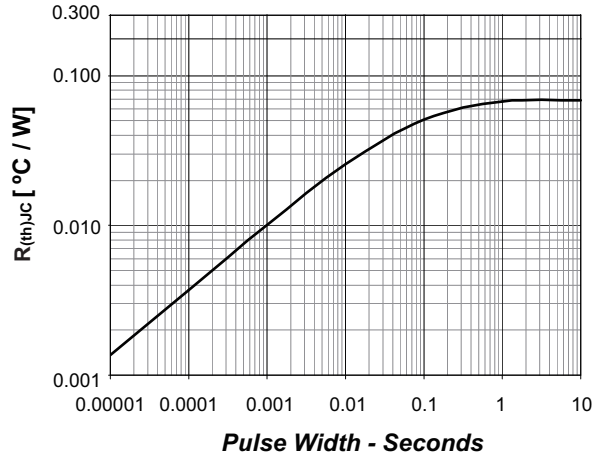


Fig 5. Typ. output characteristics

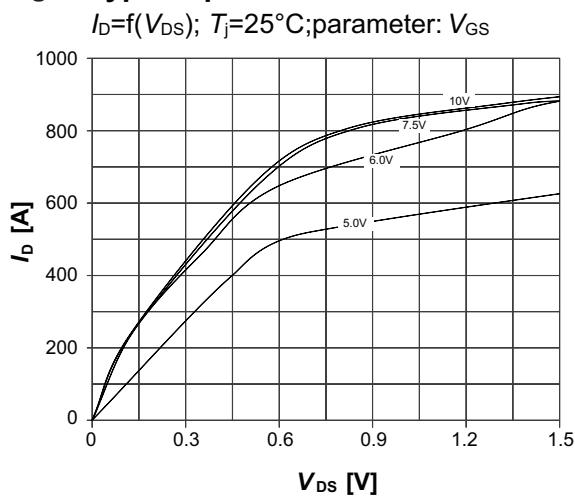
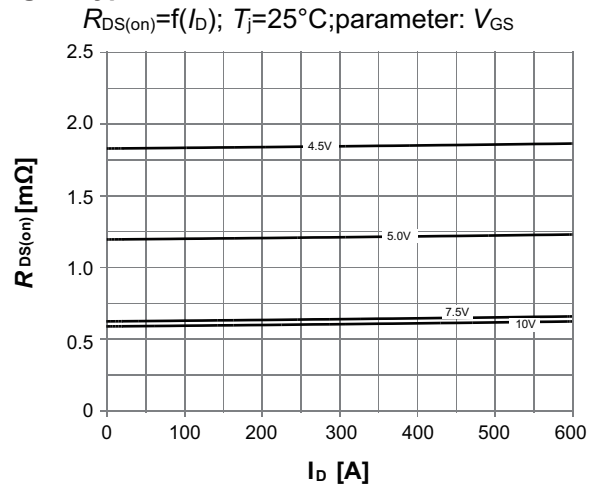


Fig 6. Typ. drain-source on resistance





Typical Characteristics

Fig 7. Typ. transfer characteristics

$I_D=f(V_{GS}); |V_{DS}|>2|I_D|R_{DS(on)max}; parameter: T_j$

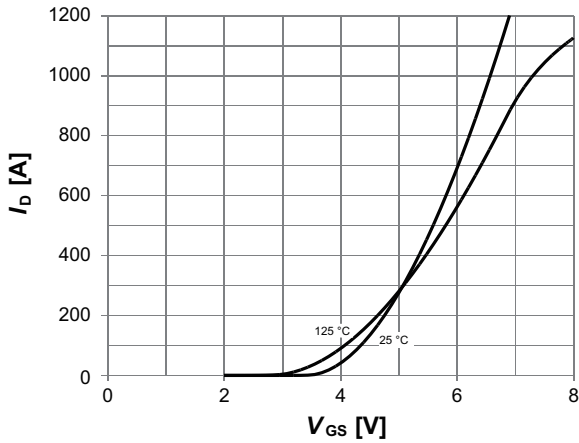


Fig 8. Typ. forward transconductance

$g_{fs}=f(I_D); T_j=25^\circ C$

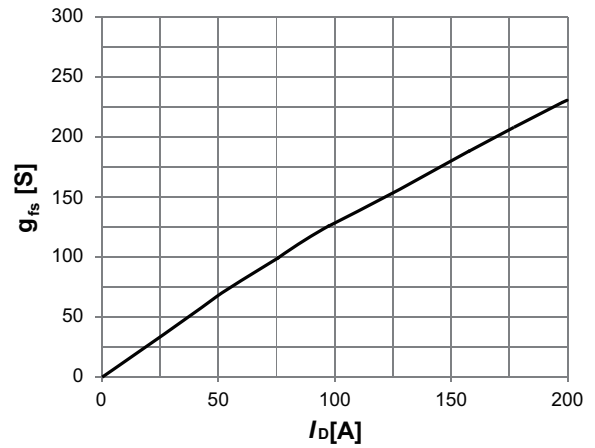


Fig 9. Drain-source on-state resistance

$R_{DS(on)}=f(T_j); I_D=400A; V_{GS}=10V$

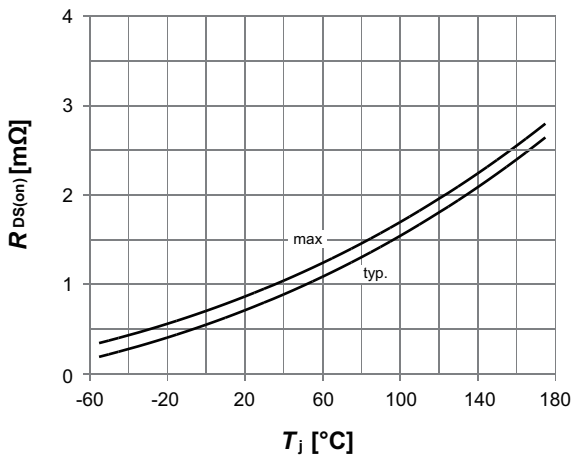


Fig 10. Typ. gate threshold voltage

$V_{GS(th)}=f(T_j); V_{GS}=V_{DS}; parameter: I_D$

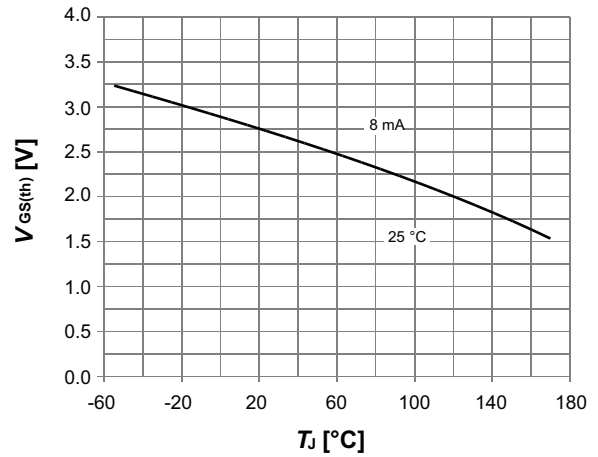


Fig 11. Typ. capacitances

$C=f(V_{DS}); V_{GS}=0V; f=1MHz$

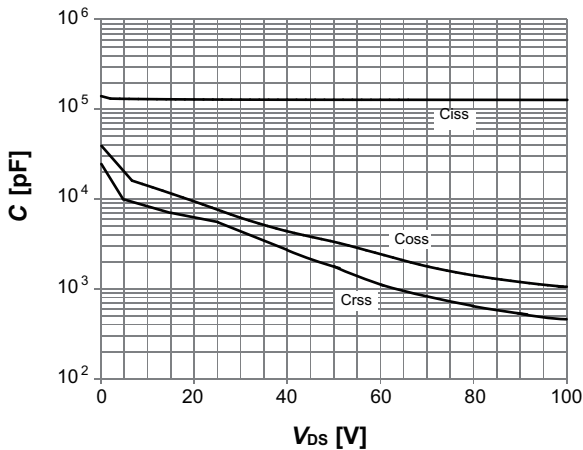
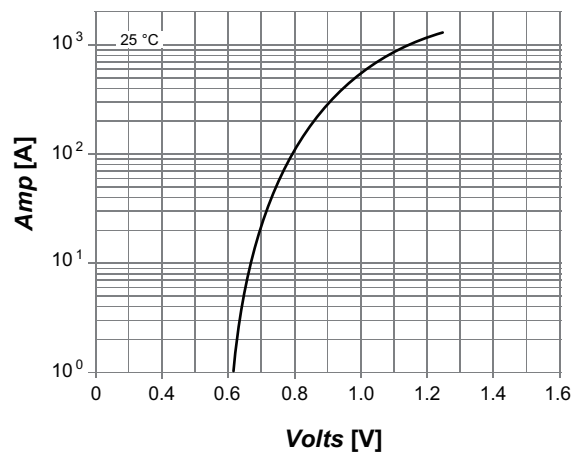


Fig 12. Typical forward characteristics of reverse diode





Typical Characteristics

Fig 13. Forward derating curve of reverse diode

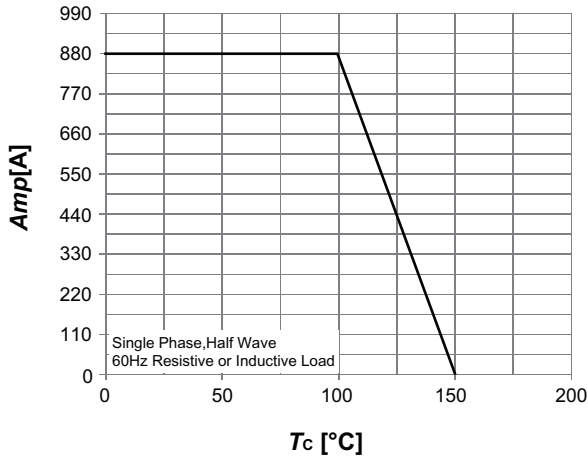


Fig 14. Peak forward surge current of reverse diode

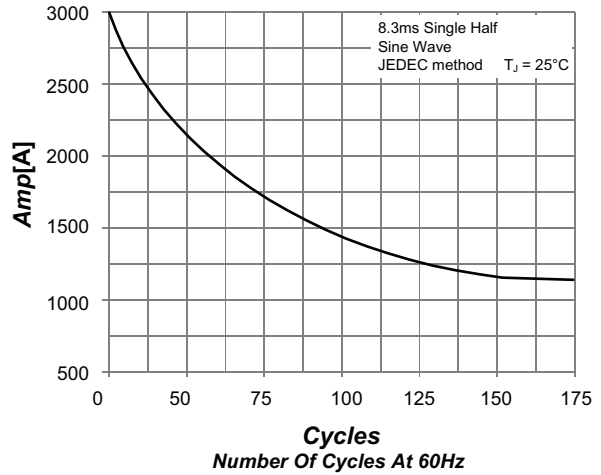


Fig 15. Typical reverse diode characteristics

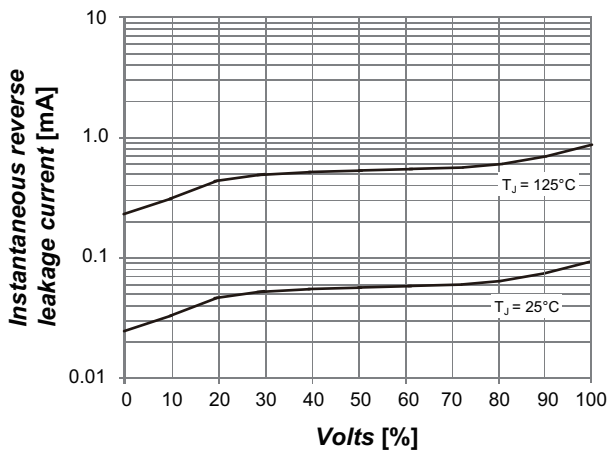


Fig 16. Typ. gate charge

V_{GS}=f(Q_{gate}); I_D=500A pulsed; parameter: V_{DD}

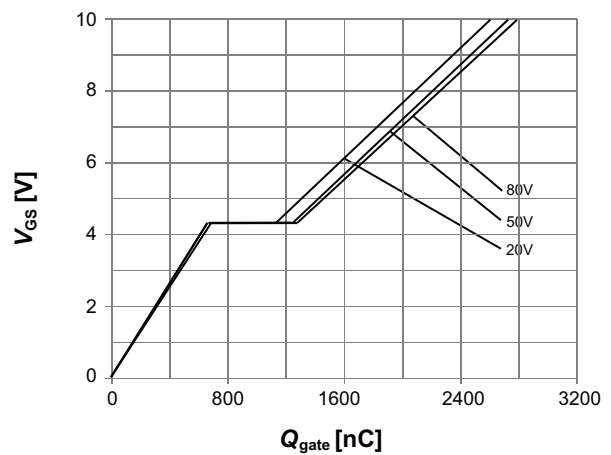
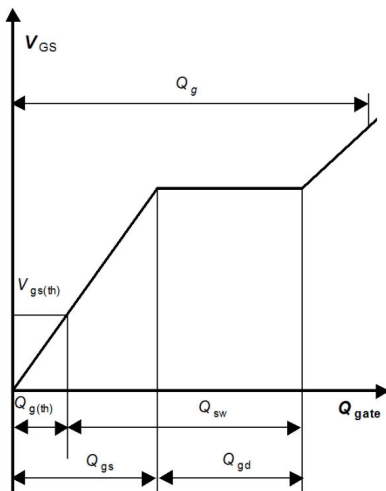


Fig 17. Gate charge waveforms





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